



In Situ Temperature Measurement Test Report

For

SHENZHEN SUNPER OPTO CO.,LTD

(Brand Name: SUNPER)

5/F,BLOK C,SANMIN INDUSTRIAL PARK,SHIYAN STREET, BAO'AN DISTRICT,SHENZHEN 518108,GUANGDONG,CHINA

Low-Bay Luminaires for Commercial and Industrial buildings

Model name(s): SP-HB-100WA

Representative (Tested) Model: SP-HB-100WA(4000K)

Model Different: All construction and rating are the same, except CCT

Test & Report By:

Sean Zhuo

Engineer: Sean Zhuo

Date: Dec.10.2014

Review By:

Manager: Tommy Liang

Tommy Liang

Note: This report does not imply product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.





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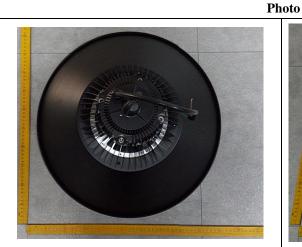




1 General

1.1 Product Information

Brand Name	SUNPER				
Model Number	SP-HB-100WA				
Luminaire Type	Low-Bay Luminaires for Commercial and Industrial				
	buildings				
Nominal Power	100 W				
Rated Initial Lamp Lumen					
Declared CCT	4000K,4500K,5000K,5700K				
[Luminaire Aperture] [Size]					
LED Manufacturer	CREE				
LED Model	Xlamp XT-E				
Sample Receipt Date	Dec.08,2014				
Sample Number	141129-1				







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1.2 Standards or methods

The following standards are partly or totally used or referenced for test:

No.	Name
ANSI/UL 1598:2008	Luminaires

1.3 Equipment list

Equipment ID	Equipment Name	Last Calibration Date	Next Calibration Date		
PF210	Power Meter	2014-07-01	2015-06-30		
ST-R-181A	Temperature Tester 2014-07-01		2015-06-30		

2 Test conducted and method

2.1 Ambient Condition

Test was conducted in an ambient temperature of 25 ± 5 °C. Ambient temperature variations above or below 25 °C was subtracted from or added to temperatures recorded at points on the luminaire.

The ambient temperature was measured by a thermocouple which was immersed in 15ml of mineral oil in a glass container.

2.2 Temperature Stabilization

Temperatures were measured after they have stabilized when the test has been running for a minimum of 7.5 hours, or the test has been running for a minimum of 3 hours and three successive reading taken at 15 minutes intervals are with 1° C of another and are not rising.





2.3 Thermocouples

Type J thermocouple was used for temperature measurement. The thermocouple was 0.05mm2(30AWG), and complied with the requirements specified in ASTM MNL 12 and limits of error specified in NIST ITS 90 and ISA MC96.1.

2.4 Thermocouples contact

Thermocouples were in contact with the TMP LED location described in LM-80 test report. In order to gain the maximum temperature, if appropriate, more than one thermocouple were contact in these locations. For details information, please refer to clause 3.3 for the photo of thermocouple contact.





3 Test Results

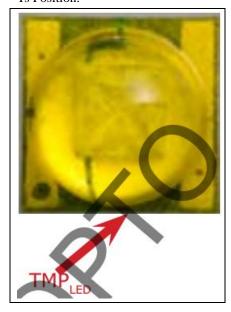
Test date		2014-12-09	Test Ambient 25.1 ℃			
Samp	le No.		LED Package Model			
1411	29-1		Xlamp XT-E			
LED driver of Each Lamp Output voltage			ge V Measured LED working current (Max.) mA			
1		44.9			1007	

3.1 Data:

Input	Vol.	120.0 V	/ Input Curr	irrent 0.81		196A	Input Wattage		96.88V	V I	Temperature abilization time:	500 min
No.	Т	emperat	erature (°C)		Tempera		ture (°C	e (°C) No.		Tempera	ture (°C)	
	Measured Corrected at 25°C			Measured		Corre	ected		Measured	Corrected		
						at 2	5°C			at 25°C		
1	75.2		75.1	3		75.4		75.3		5	75.9	75.8
2	74.6		74.5	4		74.2		74.1		6	74.8	74.7
The highest in-situ measured temperature LED is 75.8°C												

3.2 Test Photo:

Ts Position:



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Thermocouple Location on Temperature Measurement Point (TMP):

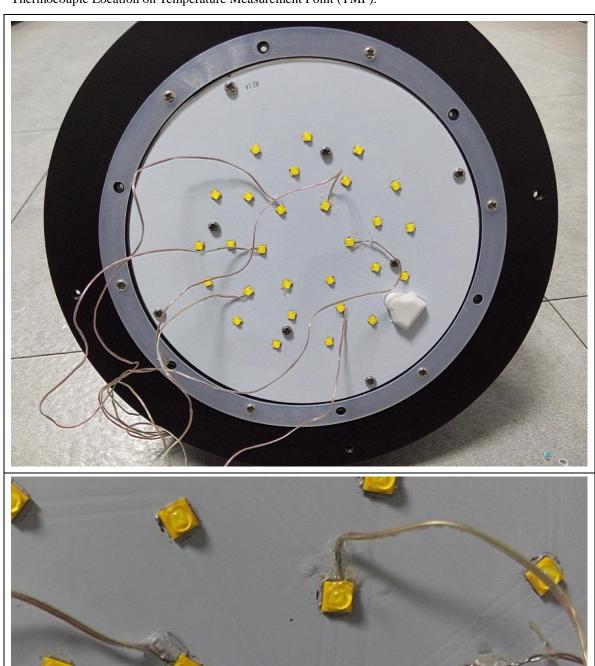






Table 1: Report at each LM-80 Test Condition							
Description of LED Ligh (manufacturer, catalog num	model,	CREE,Xlamp XT-E					
Test Condition 1 - 55°C	Case Temp	Test Condition 2 - 85°C	Case Temp				
Sample size	25	Sample size	25	Sample size	-		
Number of failures	0	Number of failures	0	Number of failures	-		
DUT drive current used in the test (mA)		DUT drive current used in the test (mA)	1250	DUT drive current used in the test (mA)	-		
Test duration (hours)	9,000	Test duration (hours)	9,000	Test duration (hours)	-		
Test duration used for projection (hour to hour)	4,032 - 9,072	Test duration used for projection (hour to hour)	4,032 - 9,072	Test duration used for projection (hour to hour)	-		
Tested case temperature (°C)	55	Tested case temperature (°C)	85	Tested case temperature (°C)	-		
α	7.907E-07	α	5.334E-06	α	-		
В	0.976	В	0.998	В	-		
Calculated L70(9k) (hours)	420,000	Calculated L70(9k) (hours)	66,000	Calculated L70(9k) (hours)	-		
Reported L70(9k) (hours) >54000		Reported L70(9k) (hours)	>54000	Reported L70(9k) (hours)	-		

	e 2: Interpolation Report ed on <i>in-situ</i> temperature entered)
T _{s,1} (°C)	55.00
T _{s,1} (K)	328.15
α_1	7.907E-07
B ₁	0.976
T _{s,2} (°C)	85.00
T _{s,2} (K)	358.15
α ₂	5.334E-06
B ₂	0.998
E _a /k _b	7.48E+03
A	6.242E+03
B ₀	0.987
T _{s,i} (°C)	75.80
T _{s,i} (K)	348.95
α_{i}	3.076E-06
Projected L70(9k) at 75.8°C (hours)	112,000
Reported L70(9k) at 75.8°C (hours)	>54000

***** END OF THE TEST REPORT*****

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